

General Description

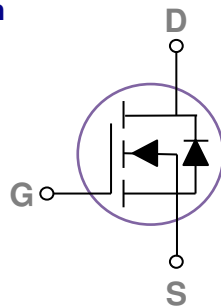
These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

BVDSS	RDSON	ID
100V	6.2mΩ	100A

Features

- 100V,100A, $R_{DS(ON)} = 6.2m\Omega @ V_{GS} = 10V$
- Improved dv/dt capability
- Fast switching
- Green Device Available

TO263 Pin Configuration



Applications

- Networking
- Load Switch
- LED applications
- Quick Charger

Absolute Maximum Ratings $T_c=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	100	V
V_{GS}	Gate-Source Voltage	+20/-12	V
I_D	Drain Current – Continuous ($T_c=25^\circ\text{C}$)	100	A
	Drain Current – Continuous ($T_c=100^\circ\text{C}$)	63	A
I_{DM}	Drain Current – Pulsed ¹	400	A
P_D	Power Dissipation ($T_c=25^\circ\text{C}$)	184	W
	Power Dissipation – Derate above 25°C	1.47	W/ $^\circ\text{C}$
T_{STG}	Storage Temperature Range	-50 to 150	$^\circ\text{C}$
T_J	Operating Junction Temperature Range	-50 to 150	$^\circ\text{C}$

Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction to ambient	---	62	$^\circ\text{C}/\text{W}$
$R_{\theta JC}$	Thermal Resistance Junction to Case	---	0.68	$^\circ\text{C}/\text{W}$

Electrical Characteristics (T_J=25 °C, unless otherwise noted)
Off Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	100	---	---	V
I _{DSS}	Drain-Source Leakage Current	V _{DS} =100V , V _{GS} =0V , T _J =25°C	---	---	1	uA
		V _{DS} =80V , V _{GS} =0V , T _J =85°C	---	---	10	uA
I _{GSS}	Gate-Source Leakage Current	V _{GS} =20V , V _{DS} =0V	---	---	100	nA

On Characteristics

R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V , I _D =20A	---	5.4	6.2	mΩ
		V _{GS} =6V , I _D =10A	---	7.7	9.5	mΩ
V _{GS(th)}	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =250uA	2	2.8	4	V
g _{fs}	Forward Transconductance	V _{DS} =10V , I _D =3A	---	12	---	S

Dynamic and switching Characteristics

Q _g	Total Gate Charge ^{2,3}	V _{DS} =80V , V _{GS} =10V , I _D =10A	---	57.9	110	nC
Q _{gs}	Gate-Source Charge ^{2,3}		---	10.8	20	
Q _{gd}	Gate-Drain Charge ^{2,3}		---	18.2	38	
T _{d(on)}	Turn-On Delay Time ^{2,3}	V _{DD} =50V , V _{GS} =10V , R _G =6Ω I _D =1A	---	24	48	ns
T _r	Rise Time ^{2,3}		---	19.8	39	
T _{d(off)}	Turn-Off Delay Time ^{2,3}		---	46	92	
T _f	Fall Time ^{2,3}		---	26	52	
C _{iss}	Input Capacitance	V _{DS} =50V , V _{GS} =0V , F=1MHz	---	3590	7180	pF
C _{oss}	Output Capacitance		---	590	1180	
C _{rss}	Reverse Transfer Capacitance		---	30	60	
R _g	Gate resistance	V _{GS} =0V , V _{DS} =0V , F=1MHz	---	1.5	3	Ω

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I _S	Continuous Source Current	V _G =V _D =0V , Force Current	---	---	100	A
I _{SM}	Pulsed Source Current		---	---	200	A
V _{SD}	Diode Forward Voltage	V _{GS} =0V , I _S =1A , T _J =25°C	---	---	1	V
t _{rr}	Reverse Recovery Time	V _{GS} =0V , I _S =10A , di/dt=100A/μs	---	60	---	ns
Q _{rr}	Reverse Recovery Charge	T _J =25°C	---	117	---	nC

Note :

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%.
3. Essentially independent of operating temperature.

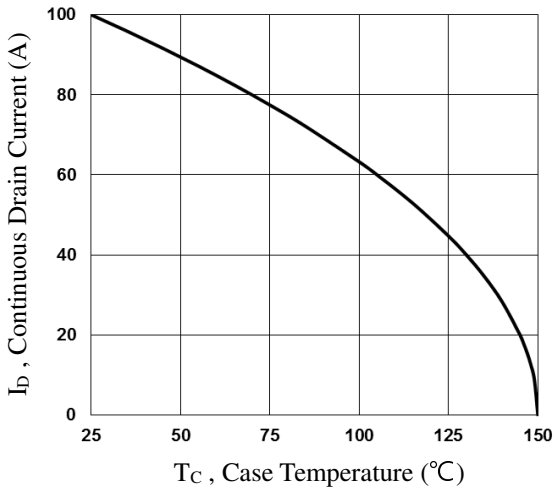


Fig.1 Continuous Drain Current vs. T_c

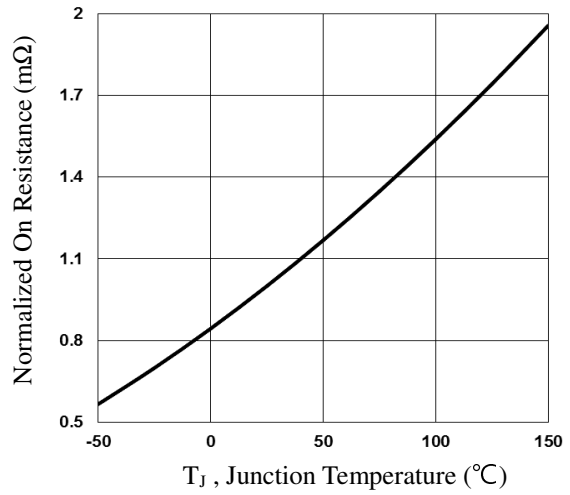


Fig.2 Normalized $R_{DS(on)}$ vs. T_j

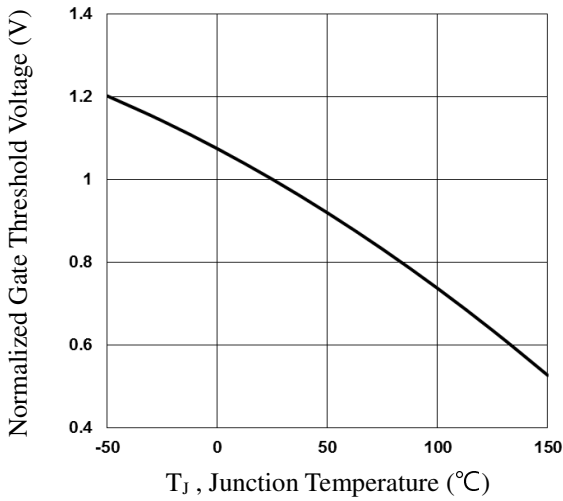


Fig.3 Normalized V_{th} vs. T_j

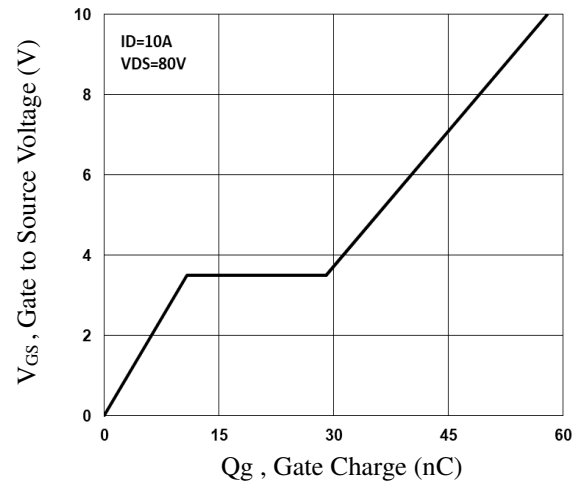


Fig.4 Gate Charge Characteristics

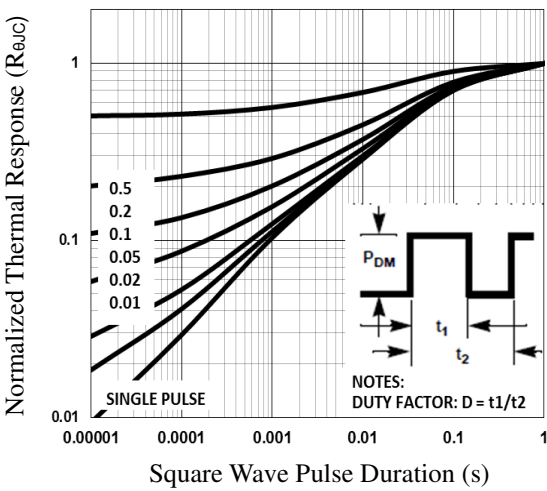


Fig.5 Normalized Transient Impedance

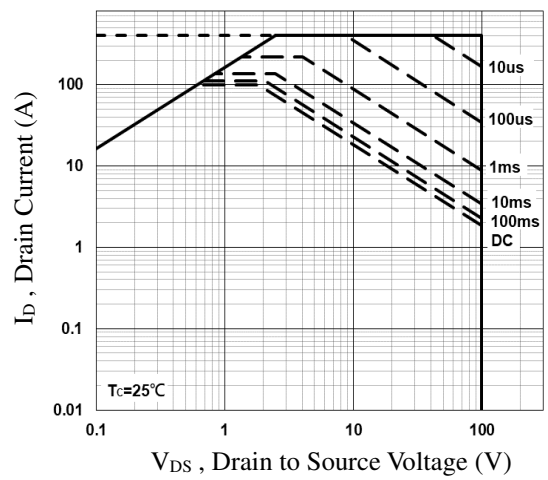


Fig.6 Maximum Safe Operation Area

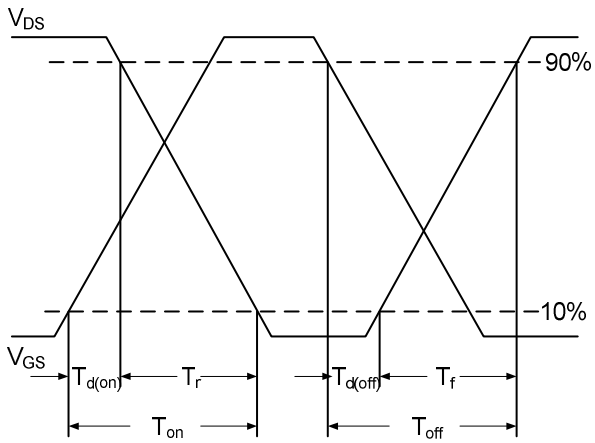


Fig.7 Switching Time Waveform

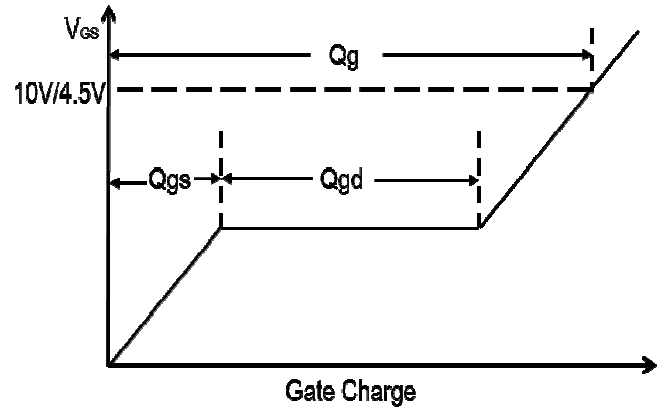


Fig.8 Gate Charge Waveform

TO263 PACKAGE INFORMATION

